Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/020,167	TANAKA, YOSHIKAZU
Examiner	**Art Unit**
Steven D. Maki	1733

SEARCHED

Class	Subclass	Date	Examiner
152	209.1 209.4 209.5 458,531		
156	117		
428	114,156		
	167,172		
	173,220		
	295.1		
	295.4		
174	117F		
24	30.5P		
	30.5T		
updated	above	1/5/2006	*SM*
152	451	1/5/2006	*SM*

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB, USPAT text search - see interference search printout		1/5/2006	*SM*

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
none	1/5/2006	*SM*